

Notice of References Cited	Application/Control No. 10/661,581	Applicant(s)/Patent Under Reexamination KWAK ET AL.	
	Examiner Jung (John) Hur	Art Unit 2824	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,367,491	11-1994	Han et al.	365/201
*	B	US-5,373,472	12-1994	Ohsawa, Takashi	365/201
*	C	US-5,896,324	04-1999	Jang et al.	365/189.07
*	D	US-6,121,806	09-2000	Kono et al.	327/205
*	E	US-6,522,589	02-2003	Miyakawa et al.	365/189.07
*	F	US-2002/0069026	06-2002	Endo, Shunsuke	702/117
*	G	US-2003/0026139	02-2003	Endou et al.	365/200
*	H	US-2003/0135801	07-2003	Chevallier, Christophe J.	714/724
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.